

Description:

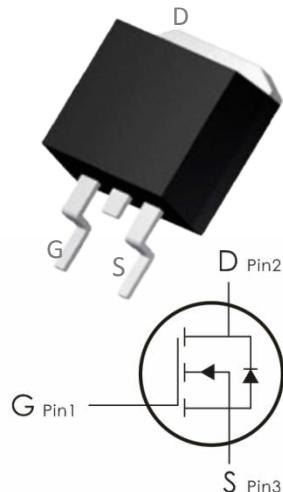
This N-Channel MOSFET uses advanced SGT technology and

design to provide excellent $R_{DS(on)}$ with low gate charge.

It can be used in a wide variety of applications.

Features:

- 1) $V_{DS}=100V, I_D=140A, R_{DS(on)}<4 m\Omega @ V_{GS}=10V$
- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density trench technology for ultra low $R_{DS(on)}$.
- 5) Excellent package for good heat dissipation.



Package Marking and Ordering Information:

Part NO.	Marking	Package	Packing
DOB14N10	14N10	TO- 263	800 pcs/Reel

Absolute Maximum Ratings: ($T_c=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
V_{DS}	Drain-Source Voltage	100	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Continuous Drain Current ¹	140	A
	Continuous Drain Current ¹ $T_c=100^\circ C$	100	
I_{DM}	Pulsed Drain Current ²	689	
P_D	Power Dissipation ⁴	312	W
E_{AS}	Single pulse avalanche energy ³	726	mJ
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55-+150	°C

Thermal Characteristics:

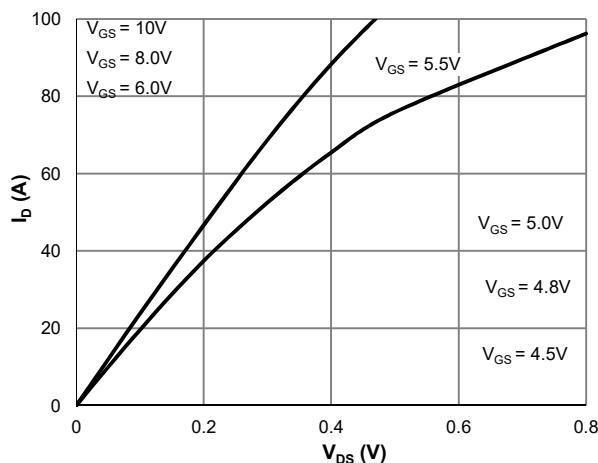
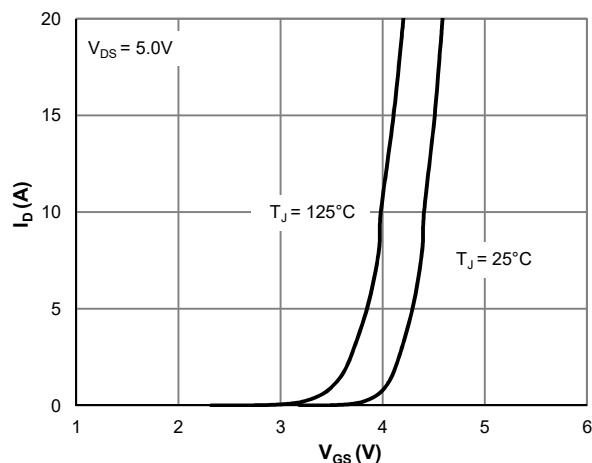
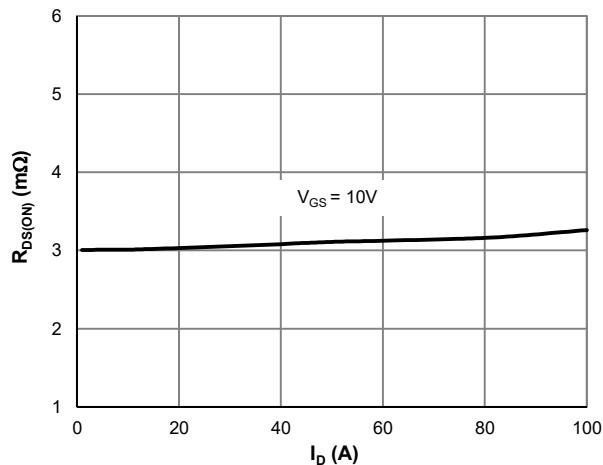
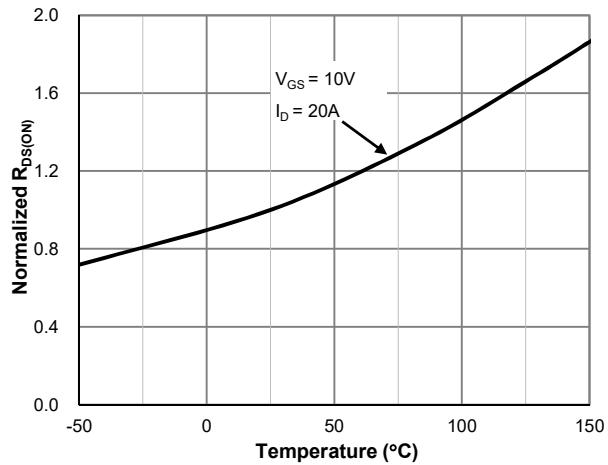
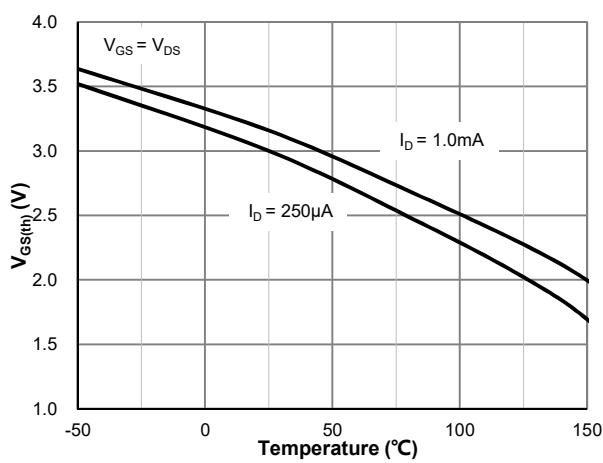
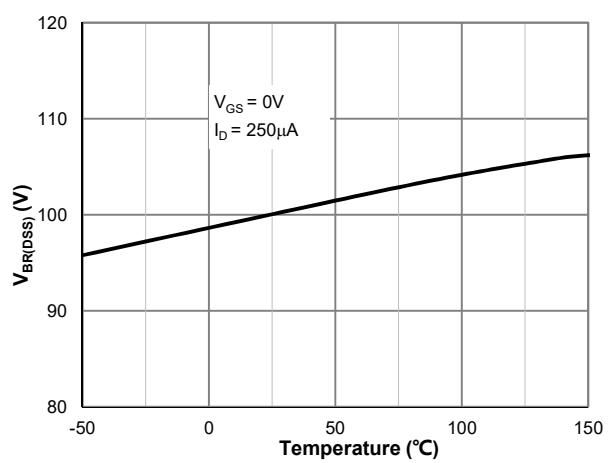
Symbol	Parameter	Max	Units
R_{eJC}	Thermal Resistance,Junction to Case	0.6	°C/W
R_{eJA}	Thermal Resistance,Junction to Ambient ⁴	55	°C/W

Electrical Characteristics: ($T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250 \mu\text{A}$	100	---	---	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=100\text{V}$	---	---	1	μA
I_{GSS}	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{A}$	---	---	± 100	nA
On Characteristics						
$V_{\text{GS(th)}}$	GATE-Source Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}, I_{\text{D}}=250 \mu\text{A}$	2	3	4	V
$R_{\text{DS(ON)}}$	Drain-Source On Resistance	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=20\text{A}$	---	3	4	$\text{m}\Omega$
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{\text{DS}}=50\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	---	4700	---	pF
C_{oss}	Output Capacitance		---	860	--	
C_{rss}	Reverse Transfer Capacitance		---	18	---	
Switching Characteristics						
$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DS}}=50\text{V}$	---	19	---	ns
t_r	Rise Time		---	34	---	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		---	48	---	ns
t_f	Fall Time		---	29	---	ns
Q_g	Total Gate Charge	$R_{\text{ENG}}=3 \Omega, V_{\text{GS}}=10\text{V}$	---	80	---	nc
Q_{gs}	Gate-Source Charge		---	23	---	nc
Q_{gd}	Gate-Drain "Miller" Charge		---	25	---	nc
Drain-Source Diode Characteristics						
V_{SD}	Diode Forward Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{SD}}=1\text{A}$	---	0.66	1	V
I_s	Continuous Drain Current	$V_D=V_G=0\text{V}$	---	---	140	A
I_{SM}	Pulsed Drain Current		---	---	689	A
Tr	Reverse Recovery Time	$I_F=20\text{A}, T_J=25^\circ\text{C}$	---	71	---	ns
Q_{rr}	Reverse Recovery Charge		---	127	---	nc

Notes:

1. Package limit
2. This single-pulse measurement was taken under $T_{J,\text{Max}} = 150^\circ\text{C}$.
3. E_{AS} of 726 mJ is based on starting $T_J = 25^\circ\text{C}$, $L = 3\text{mH}$, $I_{\text{AS}} = 22\text{A}$, $V_{\text{GS}} = 10\text{V}$, $V_{\text{DD}} = 50\text{V}$; 100% test at $L = 0.3\text{mH}$, $I_{\text{AS}} = 45\text{A}$. $T_{J,\text{Max}} = 150^\circ\text{C}$.
4. The power dissipation P_D is based on $T_{J,\text{Max}} = 150^\circ\text{C}$.
5. This value is guaranteed by design hence it is not included in the production test.

Typical Characteristics: ($T_c=25^\circ\text{C}$ unless otherwise noted)

Figure 1: Saturation Characteristics

Figure 2: Transfer Characteristics

Figure 3: $R_{DS(ON)}$ vs. Drain Current

Figure 4: $R_{DS(ON)}$ vs. Junction Temperature

Figure 5: $V_{GS(th)}$ vs. Junction Temperature

Figure 6: $V_{BR(DSS)}$ vs. Junction Temperature

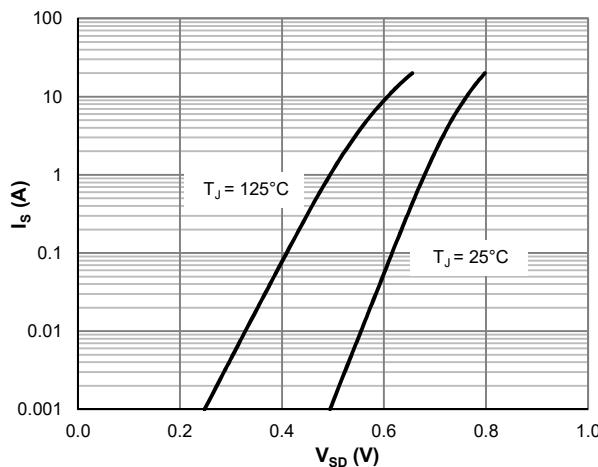


Figure 7: Body-Diode Characteristics

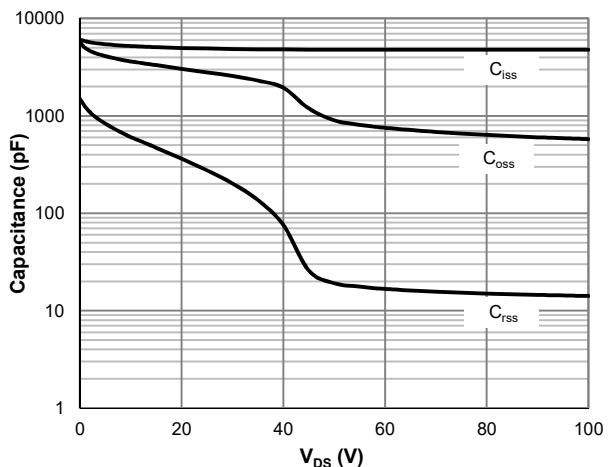


Figure 8: Capacitance Characteristics

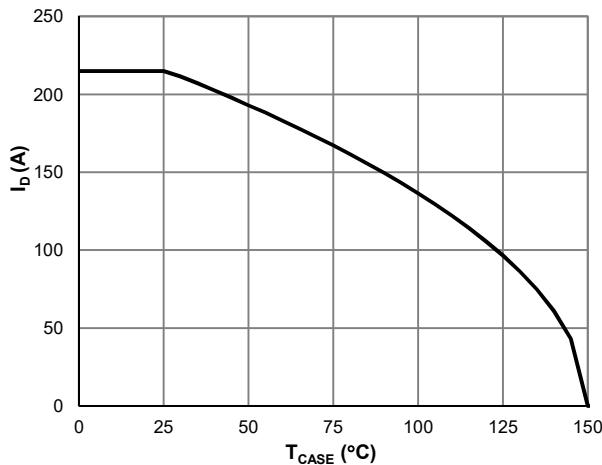


Figure 9: Current De-rating

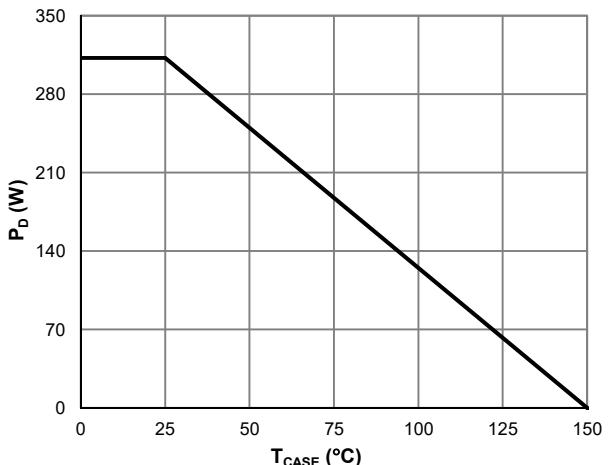


Figure 10: Power De-rating

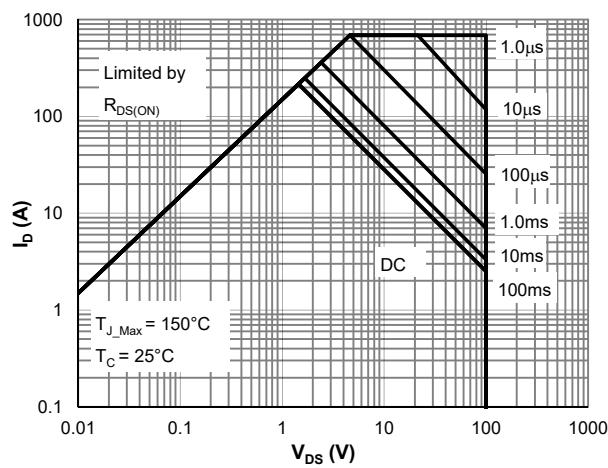


Figure 11: Maximum Safe Operating Area

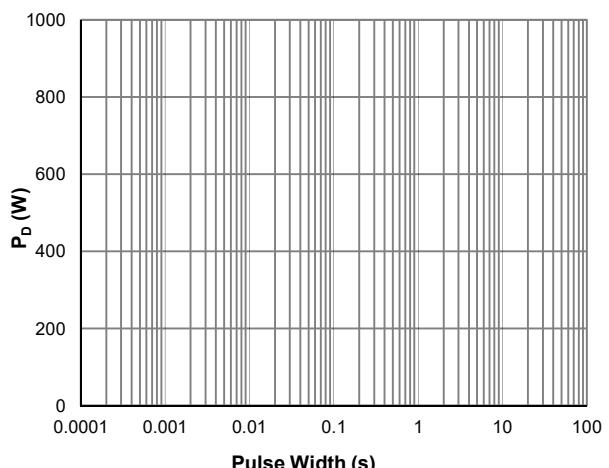


Figure 12: Single Pulse Power Rating, Junction-to-Case

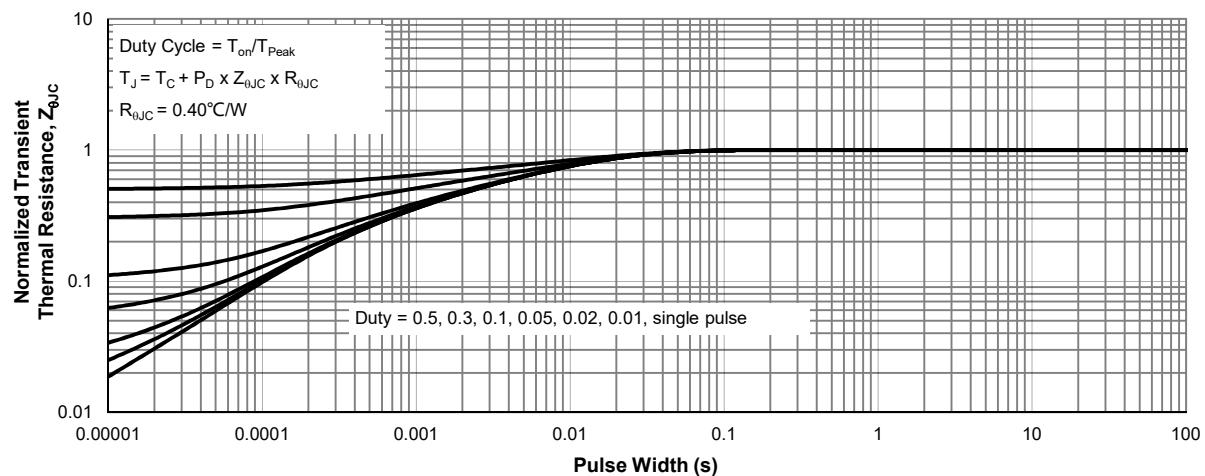
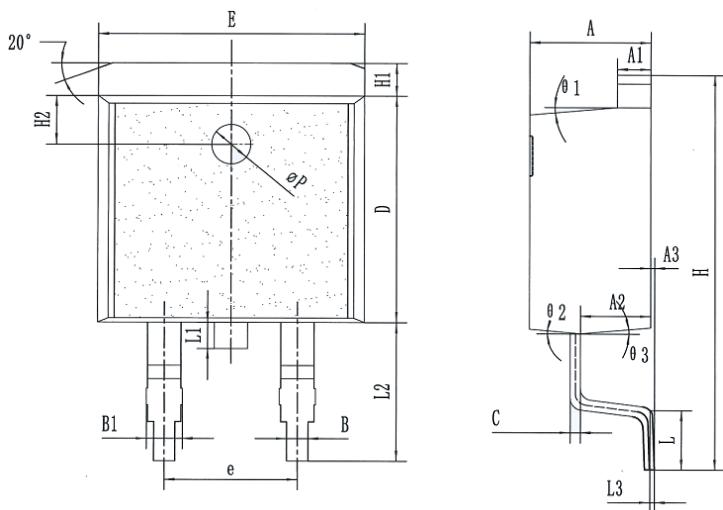


Figure 13: Normalized Maximum Transient Thermal Impedance



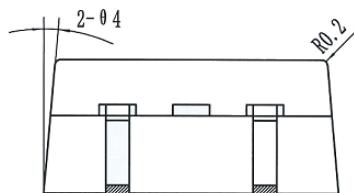
TO-263 Package Information: Unit:mm

Package Outline Type-A

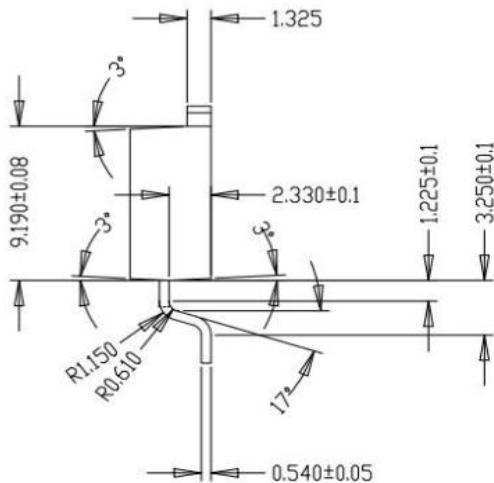
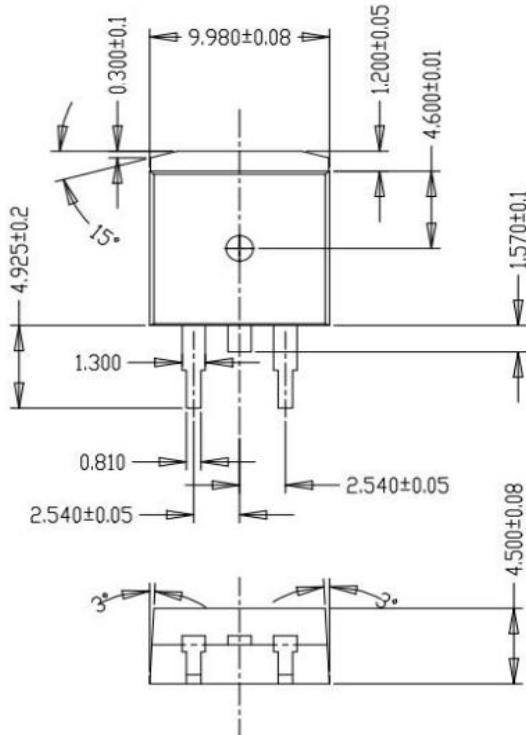


COMMON DIMENSIONS

SYMBOL	MM		
	MIN	NOM	MAX
A	4.50	4.60	4.70
A1	1.22	1.27	1.32
A2	2.57	2.67	2.77
A3	0.00		0.15
B	0.76	0.81	0.87
B1	1.32	1.37	1.42
C	0.33	0.38	0.43
D	8.55	8.65	8.75
e		5.08 BSC	
E	10.06	10.16	10.26
H	14.80	15.00	15.20
H1	1.17	1.27	1.37
H2		1.85 REF	
L	2.09	2.39	2.69
L1	0.80	1.00	1.20
L2	4.88	5.08	5.28
L3		0.25 REF	
ΦP	1.40	1.50	1.60
θ1	3°	5°	7°
θ2	3°	5°	7°
θ3	3°	5°	7°
θ4	3°	5°	7°



Package Outline Type-B



Marking Information:

①. Doingter LOGO

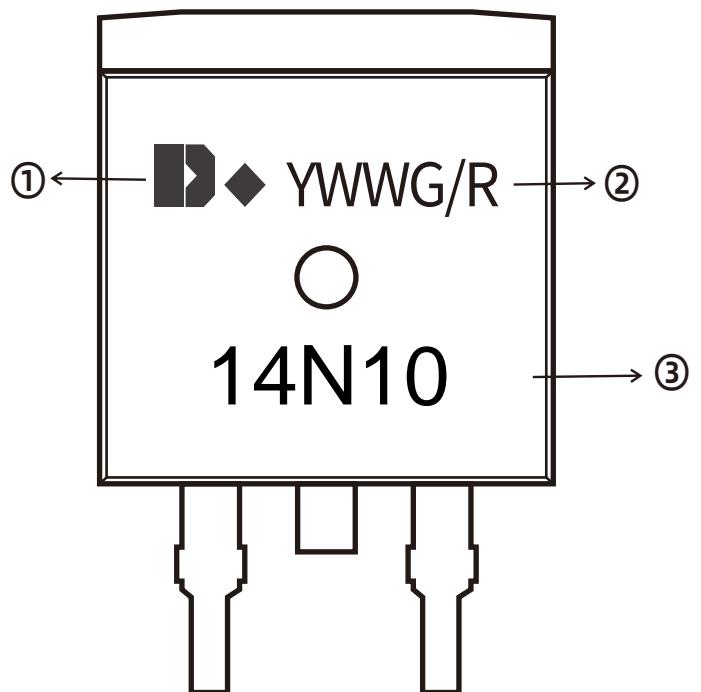
②. Date Code(YWWG / R)

Y : Year Code , last digit of the year

WW : Week Code(01-53)

G/R : G(Green) /R(Lead Free)

③. Part NO.



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